Unit: mm

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSⅢ)

SSM6J21TU

High Current Switching Applications

Suitable for high-density mounting due to compact package

• Low on resistance: $R_{on} = 88 \text{ m}\Omega \text{ (max) } (@V_{GS} = -2.5 \text{ V})$

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Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		V_{DS}	-12	V	
Gate-Source voltage		V _{GSS}	±12	V	
Drain current	DC	ID	-3	Α	
	Pulse	I _{DP}	-6		
Drain power dissipation		P _D (Note 1)	500	mW	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

2.1±0.1 1.7±0.1 1.2,5,6 : Drain 3 : Gate 4 : Source UF6

JEDEC
JEITA
TOSHIBA 2-2T1D

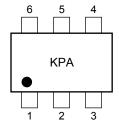
Weight: 7 mg (typ.)

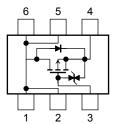
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Mounted on FR4 board. (25.4 mm \times 25.4 mm \times 1.6 t, Cu Pad: 645 mm 2)

Marking

Equivalent Circuit





Handling Precaution

When handling individual devices (which are not yet mounting on a circuit board), be sure that the environment is protected against electrostatic discharge. Operators should wear anti-static clothing and use containers and other objects that are made of anti-static materials.

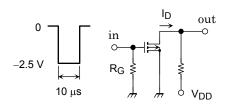
Electrical Characteristics (Ta = 25°C)

Chara	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage curr	ent	I _{GSS}	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0$	_	_	±1	μА	
Drain-Source breakdown voltage		V (BR) DSS	$I_D = -1 \text{ mA}, V_{GS} = 0$	-12	-	=	- V	
		V (BR) DSX	I _D = -1 mA, V _{GS} = +8 V	-4	_	-		
Drain cut-off curre	ent	I _{DSS}	$V_{DS} = -12 V, V_{GS} = 0$	-	_	-1	μА	
Gate threshold voltage		V _{th}	$V_{DS} = -3 \text{ V}, I_{D} = -0.1 \text{ mA}$	-0.5	_	-1.1	V	
Forward transfer admittance		Y _{fs}	$V_{DS} = -3 \text{ V}, I_D = -1.5 \text{ A}$ (Note2)	4.3	_	-	S	
Drain-Source ON resistance		R _{DS (ON)}	$I_D = -1.5 \text{ A}, V_{GS} = -4 \text{ V}$ (Note2)	-	35	50	- mΩ	
			$I_D = -1.5 \text{ A}, V_{GS} = -2.5 \text{ V}$ (Note2)	-	50	88		
Input capacitance C _{is}		C _{iss}	V _{DS} = -10 V, V _{GS} = 0, f = 1 MHz	-	1300	-	pF	
Reverse transfer capacitance (C _{rss}	V _{DS} = -10 V, V _{GS} = 0, f = 1 MHz	_	330	-	pF	
Output capacitance		Coss	V _{DS} = -10 V, V _{GS} = 0, f = 1 MHz	_	400	-	pF	
Switching time	Turn-on time	t _{on}	-	_	68	-	20	
	Turn-off time	t _{off}		-	76	-	ns	

Note2: Pulse test

Switching Time Test Circuit

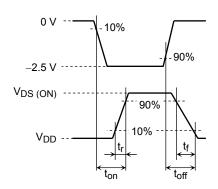
(a) Test Circuit



$$\begin{split} &V_{DD} = \text{-}10 \text{ V} \\ &R_G = 4.7 \text{ }\Omega \\ &\text{D.U.} \leq 1\% \\ &V_{IN}\text{: } t_r, t_f < 5 \text{ ns} \\ &\text{Common Source} \\ &Ta = 25^{\circ}\text{C} \end{split}$$

(b) V_{IN}

(c) V_{OUT}

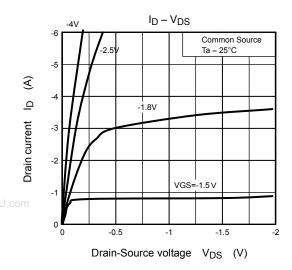


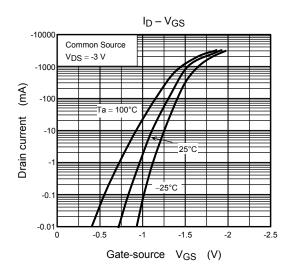
Precaution

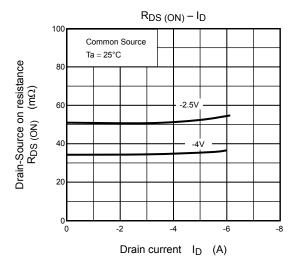
 V_{th} can be expressed as voltage between gate and source when low operating current value is ID = -100 μA for this product. For normal switching operation, V_{GS} (on) requires higher voltage than V_{th} and V_{GS} (off) requires lower voltage than V_{th} .

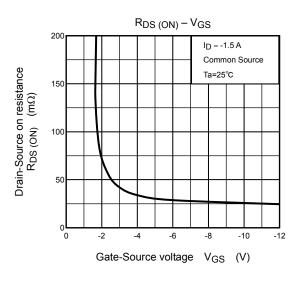
(Relationship can be established as follows: V_{GS} (off) < V_{th} < V_{GS} (on))

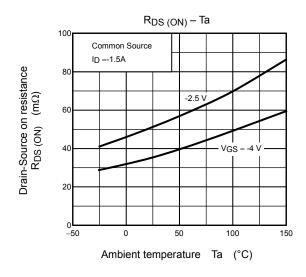
Please take this into consideration for using the device.

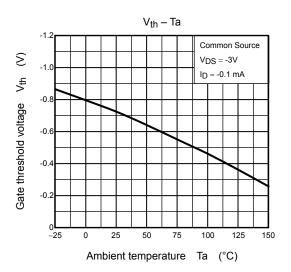


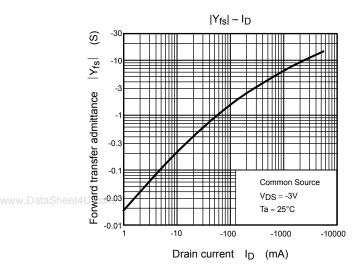


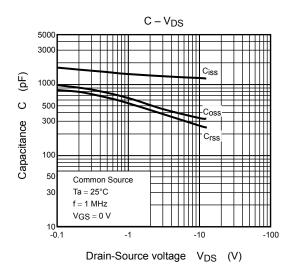


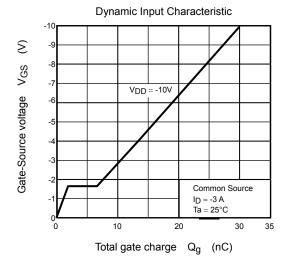


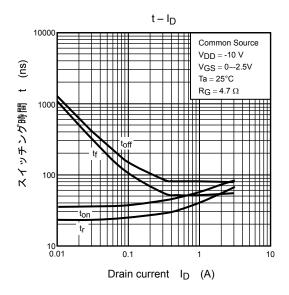


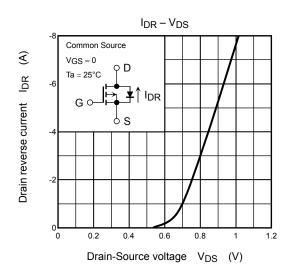




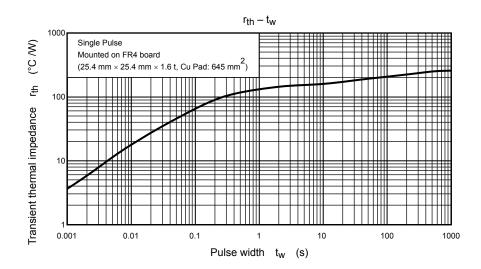


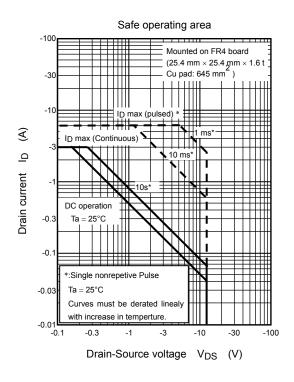


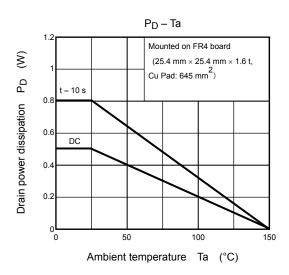




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